



# Carrier Concentrations

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# Carrier Concentration

- Carrier Properties
- State and Carrier Distributions
- Equilibrium Carrier Concentration
- Carrier Concentration for the Quantum Well Devices

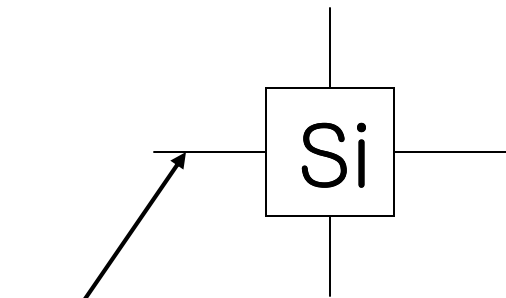


# Carrier Properties

- Carrier Movement in Free Space
- Carrier Movement Within the Crystal
- Intrinsic Carrier Concentration
- Extrinsic n-Type Semiconductor
- Extrinsic p-Type Semiconductor

# Electronic Materials

- Two-dimensional representation of an Individual Si atom.

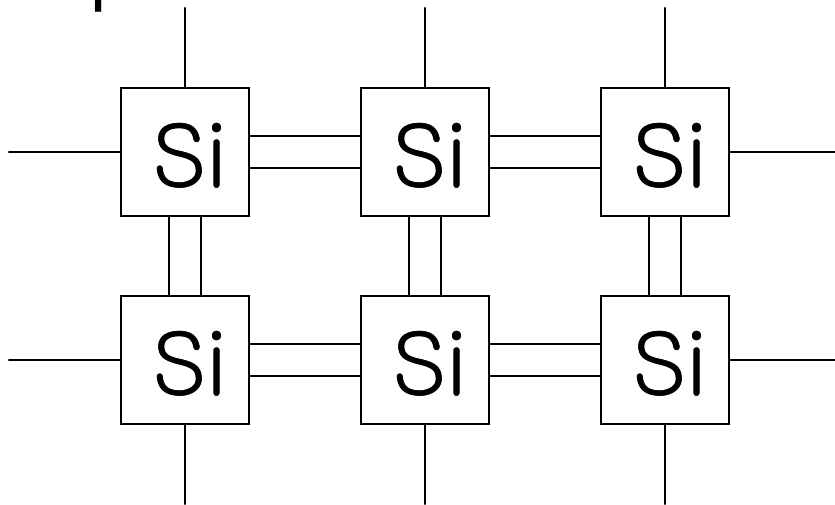


Represents each valence electron

Elemental semiconductors			
Valence	III	IV	V
	B	C	
	Al	Si	P
	Ga	Ge	As

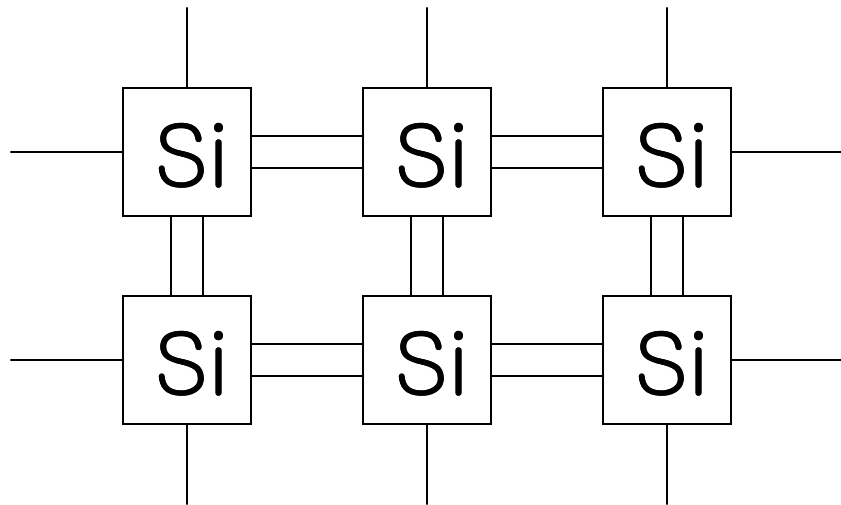
# Semiconductors

- When Si (or Ge & GaAs) atoms contact other Si atoms, they form a tetrahedral
- 2D representation of lattice structure:

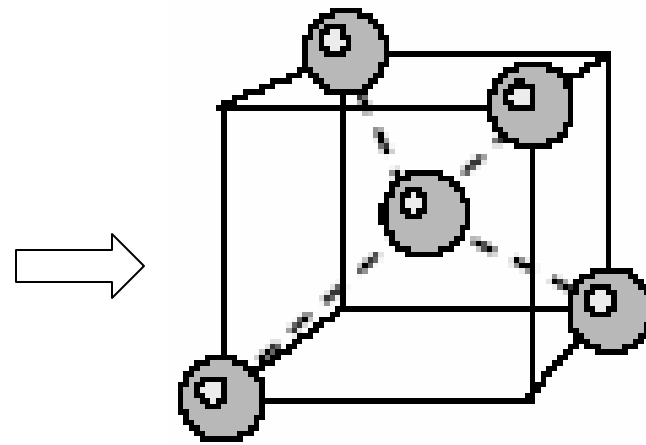


# Electronic Materials

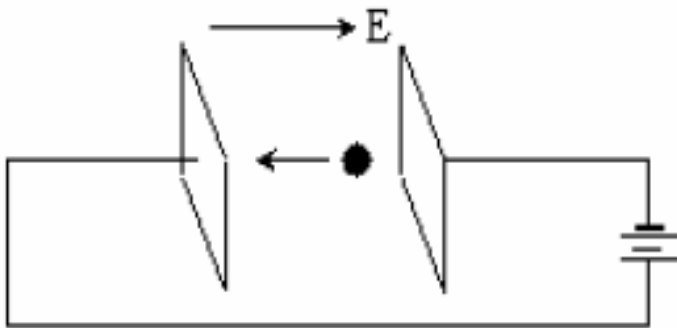
Two dimensions



Three dimensions



# Carrier Movement in Free Space

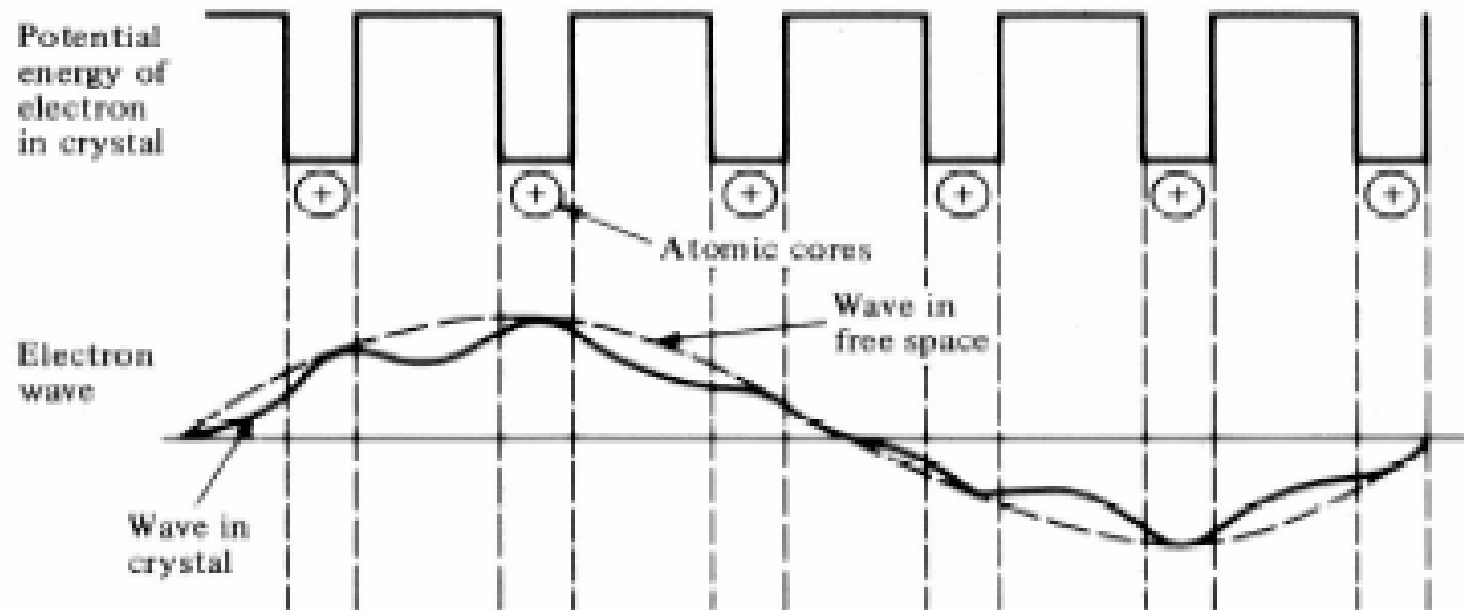


Newton's second law

$$F = -qE = m_0 \frac{dv}{dt}$$

# Carrier Movement Within the Crystal

- Electrons moving inside a semiconductor crystal will collide with semiconductor atoms ==> behaves as a “wave” due to the quantum mechanical effects
- The electron “wavelength” is perturbed by the crystals periodic potential





# Carrier Movement Within the Crystal

$m_n^*$  (electron effective mass)

$m_p^*$  (hole effective mass)



$$F = -qE = m_n^* \frac{dv}{dt}$$

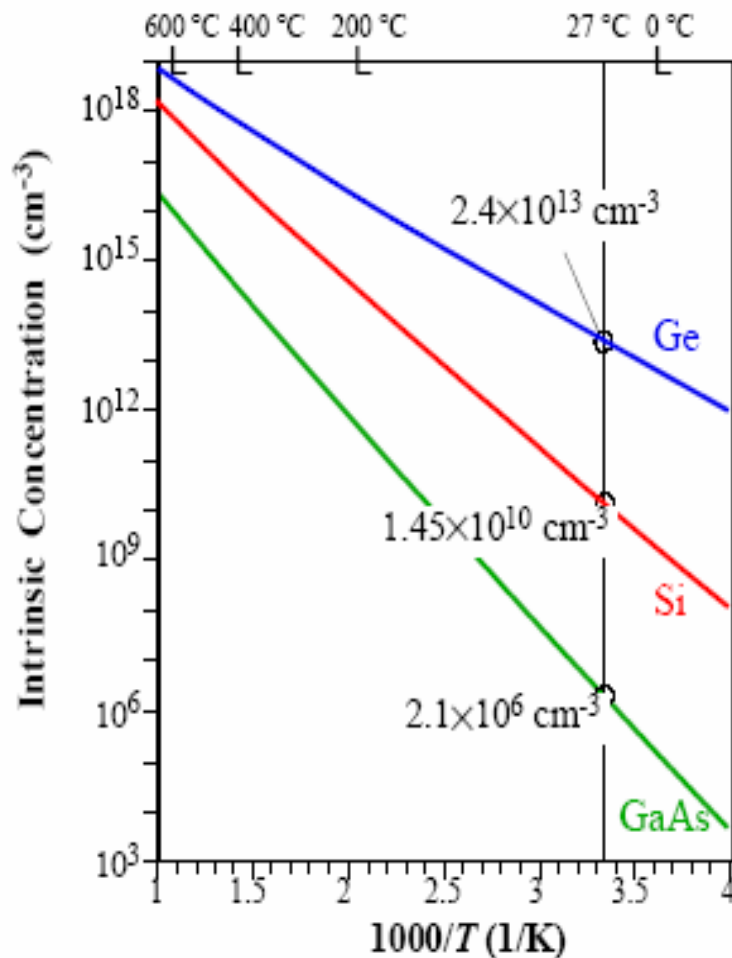


$$F = -qE = m_p^* \frac{dv}{dt}$$

Material	$m_n^* / m_0$	$m_p^* / m_0$
Si	1.18	0.81
Ge	0.55	0.36
GaAs	0.066	0.52

Density of States Effective Masses at 300 K

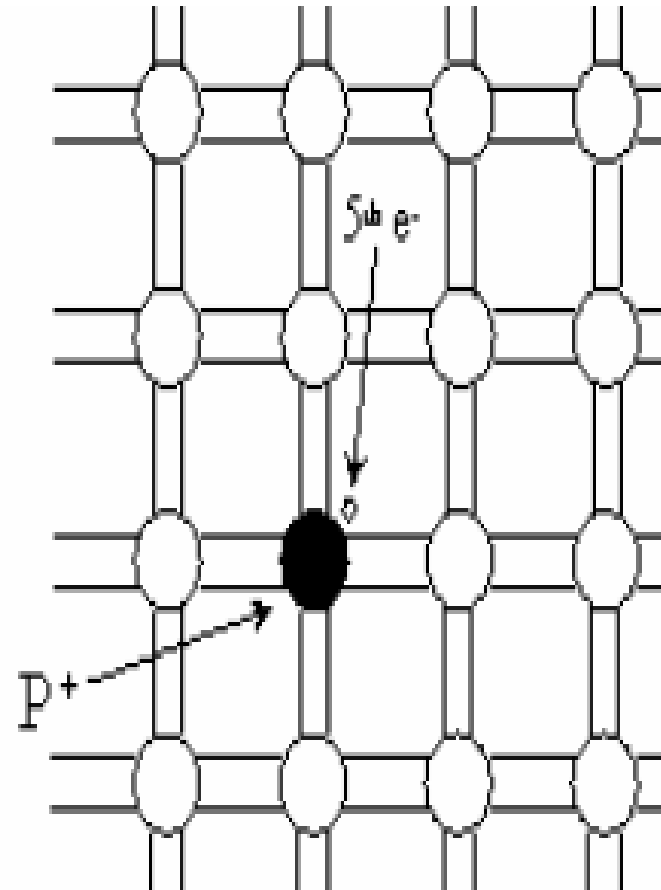
# Intrinsic Carrier Concentration



- Contains an insignificant concentration of impurity atoms
- Under the equilibrium conditions, for every electron is created, a hole is created also  
$$n = p = n_i$$
- As temperature is increased, the number of broken bonds (carriers) increases
- As the temperature is decreased, electrons do not receive enough energy to break a bond and remain in the valence band.

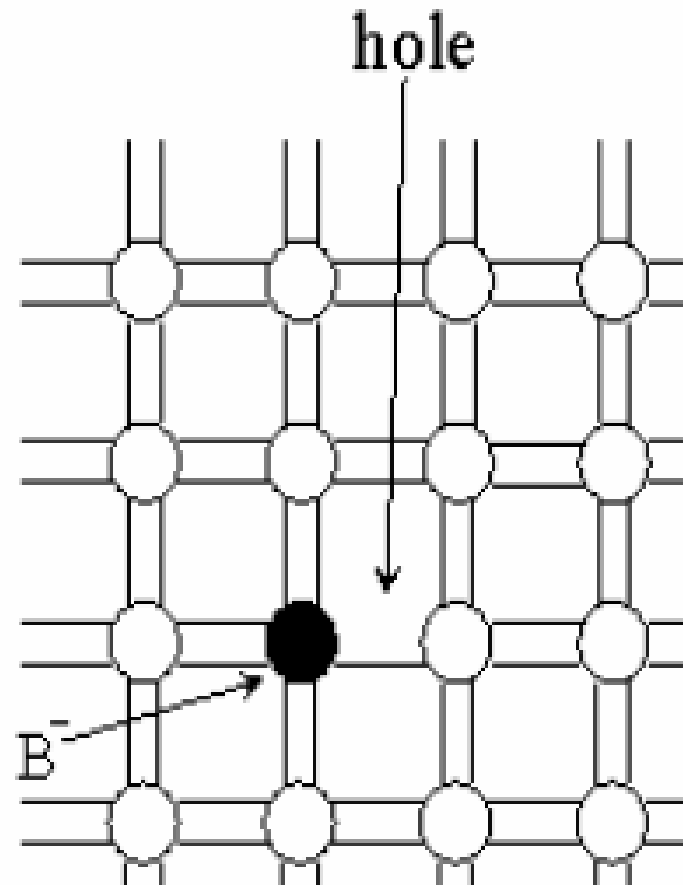
# Extrinsic n-Type Semiconductor

- Donors (Group V): The 5<sup>th</sup> in a five valence electrons is readily freed to wander about the lattice at room temperature
- There is no room in the valence band so the extra electron becomes a carrier in the conduction band
- Does NOT increase the number of hole concentration



# Extrinsic p-Type Semiconductor

- Acceptors (Group III) : three valence electrons readily accept an electron from a nearby Si-Si bond
- Completing its own bonding creates a hole that can wander about the lattice
- Does NOT increase the number of electron concentration





# State and Carrier Distribution

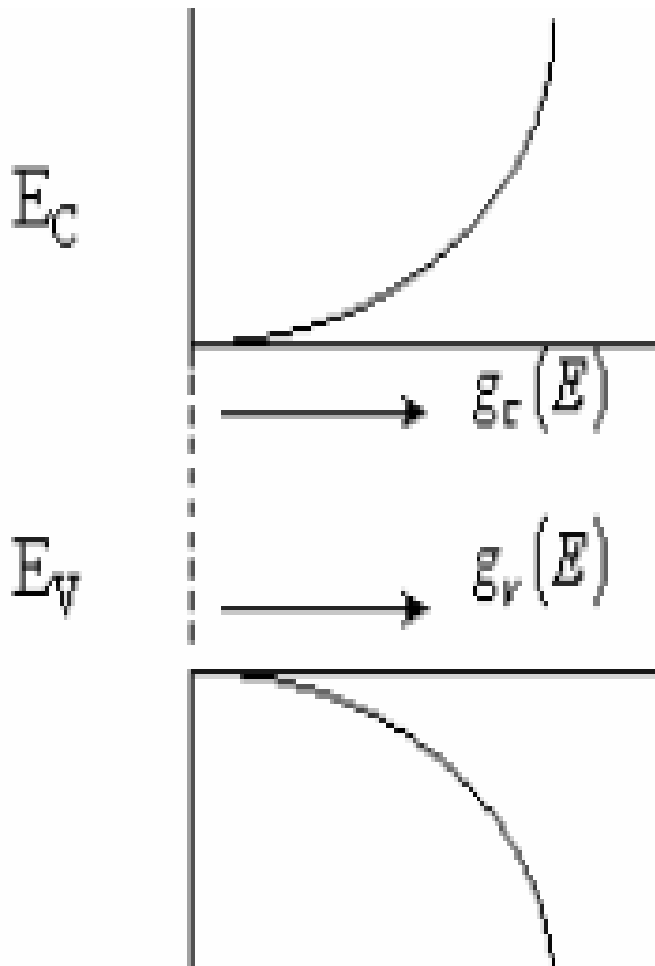
- How the allowed energy states are distributed in energy
- How many allowable states were to be found at any given energy in the conduction and valence bands?
- Essential component in determining carrier distributions and concentration

- Density of States

- Fermi Function

- Dopant States

Density of States:  $\left( \frac{\text{Number of States}}{\text{cm}^3} \right) / \text{eV}$



$$g_c(E) = \frac{m_n^* \sqrt{2m_n^* (E - E_c)}}{\pi^2 \hbar^3}, \quad E \geq E_c$$

- $g_c(E)dE$  represents the number of conduction band states/  $\text{cm}^3$  lying in the energy range between  $E$  and  $E + dE$

$$g_v(E) = \frac{m_p^* \sqrt{2m_p^* (E_v - E)}}{\pi^2 \hbar^3}, \quad E \leq E_v$$

- $g_v(E)dE$  represents the number of valence band states/  $\text{cm}^3$  lying in the energy range between  $E$  and  $E + dE$

$$g_c(E_c) = g_v(E_v) = 0$$



# Fermi Function (I)

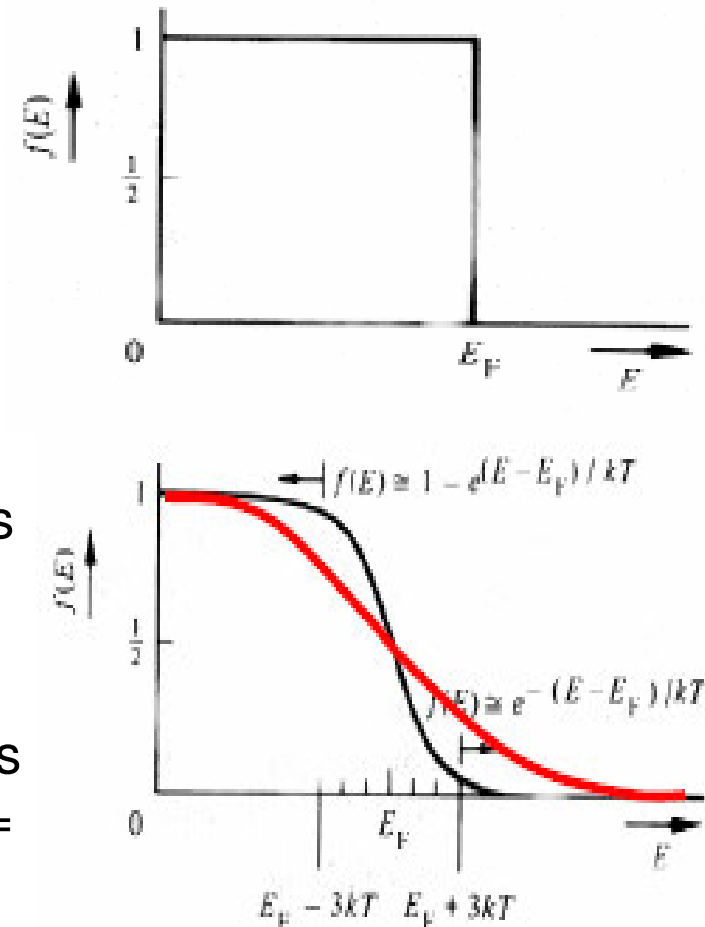
- How many of the states at the energy  $E$  will be filled with an electron

$$f(E) = \frac{1}{1 + e^{(E - E_F) / kT}}$$

- $f(E)$ , under equilibrium conditions, the probability that an available state at an energy  $E$  will be occupied by an electron
- $1 - f(E)$ , under equilibrium conditions, the probability that an available state at an energy  $E$  will NOT be occupied by an electron

# Fermi Function (II)

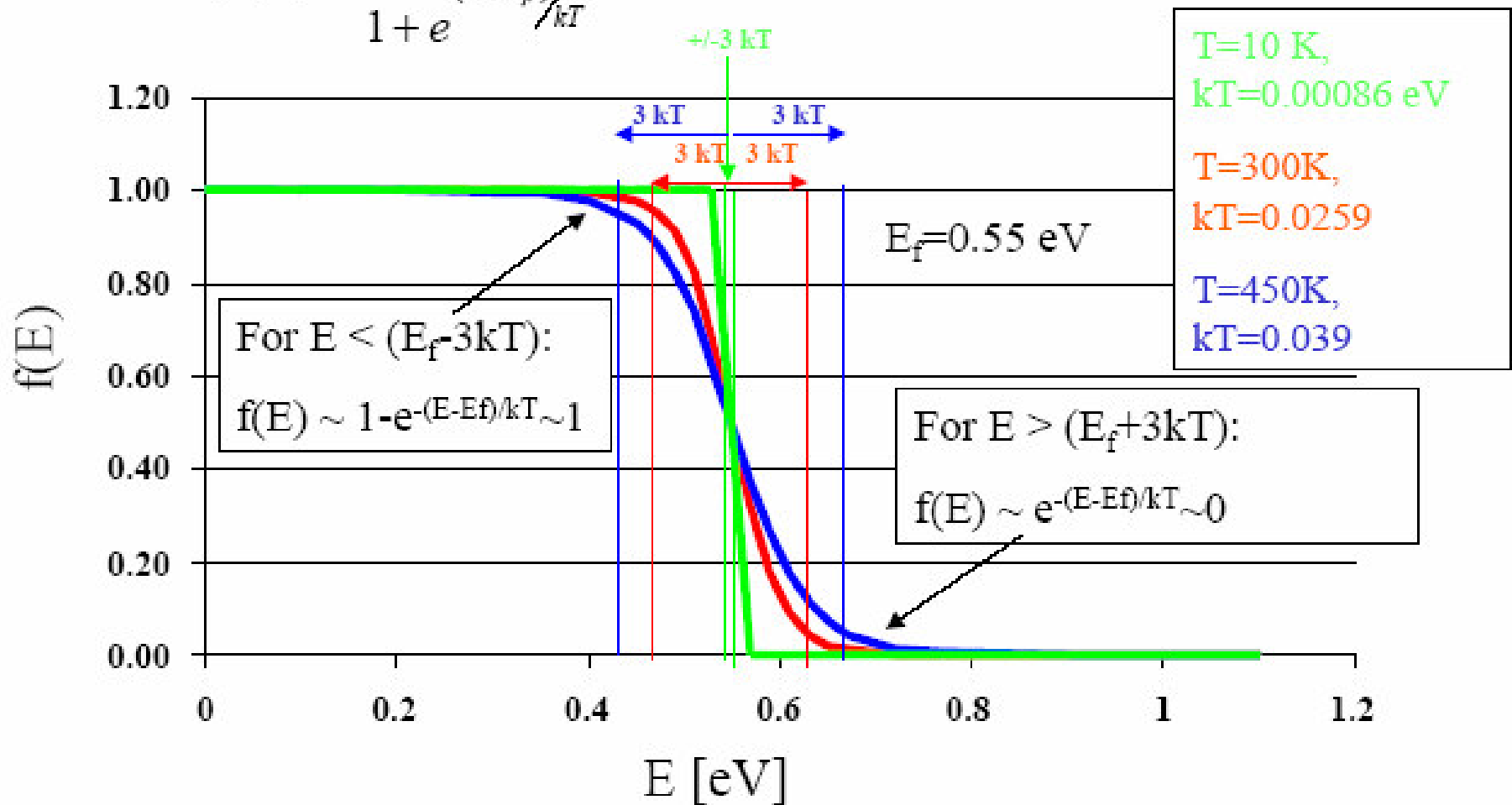
- If  $E = E_F$ ,  $f(E_F) = 1/2$
- If  $E \geq E_F + 3k_B T$ ,  
 $f(E) \approx \exp[(E_F - E)/k_B T]$
- If  $E \leq E_F - 3k_B T$ ,  
 $f(E) \approx 1 - \exp[(E - E_F)/k_B T]$
- At  $T=0K$  (above), No occupation of states above  $E_F$  and complete occupation of states below  $E_F$
- At  $T>0K$  (below), occupation probability is reduced with increasing energy  $f(E=E_F) = 1/2$  regardless of temperature.
- At higher temperatures, higher energy states can be occupied, leaving more lower energy states unoccupied ( $1-f(E)$ )





# Fermi Function (III)

$$f(E) = \frac{1}{1 + e^{(E-E_f)/kT}}$$

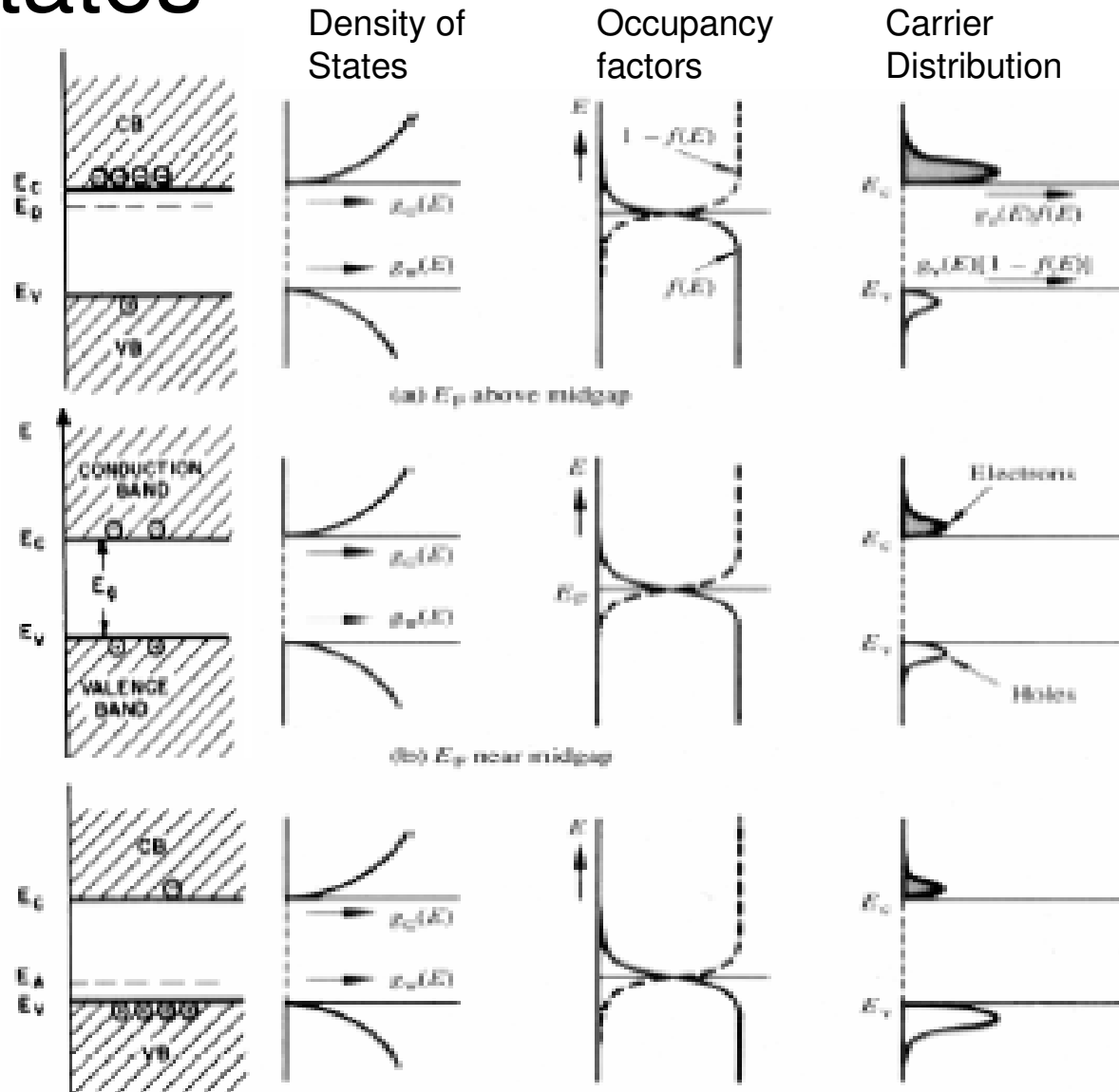


# Dopant States

n-type: more electrons than Holes

Intrinsic: Equal number of electrons and holes

p-type: more holes than electrons





# Equilibrium Carrier Concentration

- Formulas for  $n$  and  $p$
- Degenerate vs. Non-degenerate Semiconductor
- Alternative Expressions for  $n$  and  $p$
- $n_i$  and the  $np$  Product
- Charge Neutrality Relationship
- Carrier Concentration Calculations
- Determination of  $E_F$

# Formulas for n and p

$$n = \int_{E_c}^{E_{top}} g_c(E) f(E) dE$$

$$n = \frac{m_n^* \sqrt{2m_n^*}}{\pi^2 \hbar^3} \int_{E_c}^{E_{top}} \frac{\sqrt{(E - E_c)}}{1 + e^{(E - E_F)/kT}} dE$$

Letting  $\eta = \frac{E - E_c}{kT}$  and  $\eta_c = \frac{E_F - E_c}{kT}$

when  $E = E_c$  ,  $\eta = 0$

Let  $E_{Top} \rightarrow \infty$

$$n = \frac{m_n^* \sqrt{2m_n^*} (kT)^{3/2}}{\pi^2 \hbar^3} \underbrace{\int_{E_0}^{E_\infty} \frac{\eta^{1/2}}{1 + e^{(\eta - \eta_c)}} d\eta}_{F_{1/2}(\eta_c)}$$

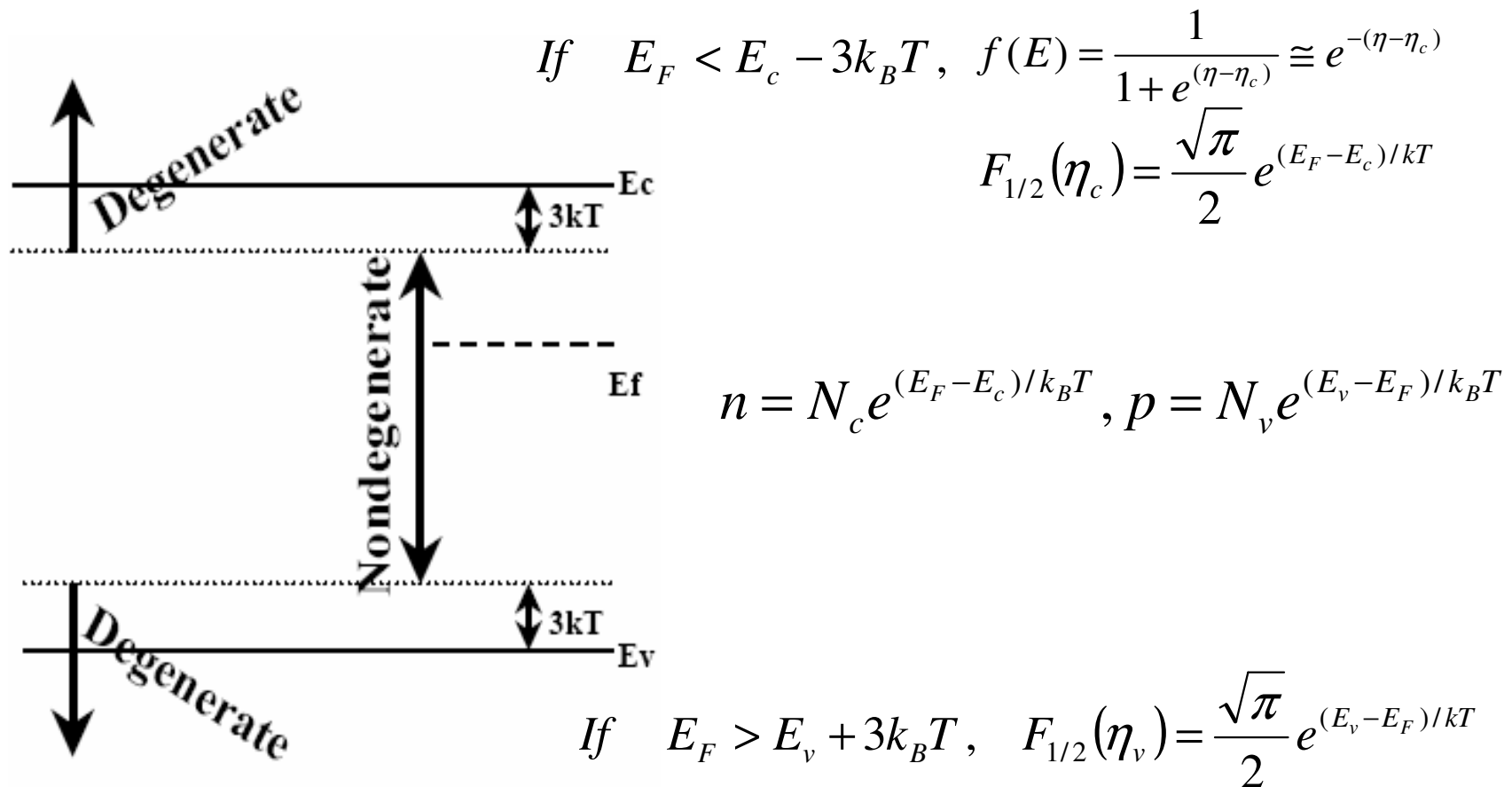
$$p = \int_{E_{bottom}}^{E_v} g_v(E) [1 - f(E)] dE$$

$$N_c = 2 \left[ \frac{2\pi m_n^* kT}{h^2} \right]^{3/2}, N_v = 2 \left[ \frac{2\pi m_p^* kT}{h^2} \right]^{3/2}$$

$$n \equiv N_c \frac{2}{\sqrt{\pi}} F_{1/2}(\eta_c)$$

$$p \equiv N_v \frac{2}{\sqrt{\pi}} F_{1/2}(\eta_v)$$

# Degenerate vs. Non-degenerate Semiconductor



# Alternative Expressions for $n$ and $p$

$$n_0 = N_c e^{(E_F - E_c)/k_B T} \quad p_0 = N_v e^{(E_v - E_F)/k_B T}$$

When  $n=n_i$ ,  $E_F = E_i$ , then

$$n_i = N_c e^{(E_i - E_c)/k_B T} = N_v e^{(E_v - E_i)/k_B T}$$

$$N_c = n_i e^{(E_c - E_i)/k_B T}, \quad N_v = n_i e^{(E_i - E_v)/k_B T}$$

$$n_0 = n_i e^{(E_c - E_i + E_F - E_c)/k_B T} = n_i e^{(E_F - E_i)/k_B T}$$

$$p_0 = n_i e^{(E_i - E_v + E_v - E_F)/k_B T} = n_i e^{(E_i - E_F)/k_B T}$$

$$n_0 p_0 = n_i^2$$

# $n_i$ and the np Product

$$n_i = N_c e^{(E_i - E_c)/k_B T} = N_v e^{(E_v - E_i)/k_B T}$$

$$n_i^2 = N_c N_v e^{-(E_c - E_v)/k_B T} = N_c N_v e^{-E_g/k_B T}$$

$$n_i = \sqrt{N_c N_v} e^{-E_g/2k_B T}$$

# Charge Neutrality Relationship

- For uniformly doped semiconductor:

Charge must be balanced under equilibrium conditions otherwise charge would flow

$$\underbrace{qp - qn}_{\text{Thermally generated}} - \underbrace{qN_A^- + qN_D^+}_{\text{assume ionization of all dopant sites}} = 0$$

Thermally generated + assume ionization of  
dopant addition all dopant sites



# Carrier Concentration Calculations

$$(p - N_A) + (N_D - n) = 0$$

$$\left(\frac{n_i^2}{n} - N_A\right) + (N_D - n) = 0$$

$$n^2 - n(N_D - N_A) - n_i^2 = 0$$

$$n = \frac{N_D - N_A}{2} + \left[ \left( \frac{N_D - N_A}{2} \right)^2 + n_i^2 \right]^{1/2}, \quad p = \frac{N_A - N_D}{2} + \left[ \left( \frac{N_A - N_D}{2} \right)^2 + n_i^2 \right]^{1/2}$$

$$np = n_i^2$$

# Relationship for $N_D^+$ and $N_A^-$

$$N_A^- = \frac{N_A}{1 + g_A \frac{(E_A - E_F)/kT}{1}}, N_D^+ = \frac{N_D}{1 + g_D \frac{(E_F - E_D)/kT}{1}}$$

- The degeneracy factors account for the possibility of electrons with different spin, occupying the same energy level (no electron with the same quantum numbers can occupy the same state)
- Most semiconductor  $g_D=2$  to account for the spin degeneracy at the donor sites
- $g_A$  is 4 due to the above reason combined with the fact that there are actually 2 valence bands in most semiconductors  
Thus, 2 spins x 2 valence bands makes  $g_A=4$

# Determination of $E_F$ (Intrinsic Material)

$$n = N_c e^{(E_i - E_c)/k_B T} = N_v e^{(E_v - E_i)/k_B T} = p$$

$$N_c e^{(E_i - E_c)/k_B T} = N_v e^{(E_v - E_i)/k_B T}$$

$$E_i = \frac{E_c + E_v}{2} + \frac{k_B T}{2} \ln\left(\frac{N_v}{N_c}\right)$$

$$N_c = 2 \left[ \frac{2\pi m_n^* k T}{h^2} \right]^{3/2}, N_v = 2 \left[ \frac{2\pi m_p^* k T}{h^2} \right]^{3/2} \implies \frac{N_v}{N_c} = \left( \frac{m_p^*}{m_n^*} \right)^{1/2}$$

$$E_i = \frac{E_c + E_v}{2} + \frac{3k_B T}{4} \ln\left(\frac{m_p^*}{m_n^*}\right)$$

# Determination of $E_F$ (Extrinsic Material)

$$n = n_i e^{(E_F - E_i)/k_B T} \quad , \quad p = n_i e^{(E_i - E_F)/k_B T}$$

$$E_F - E_i = kT \ln\left(\frac{n}{n_i}\right) = -kT \ln\left(\frac{p}{n_i}\right)$$

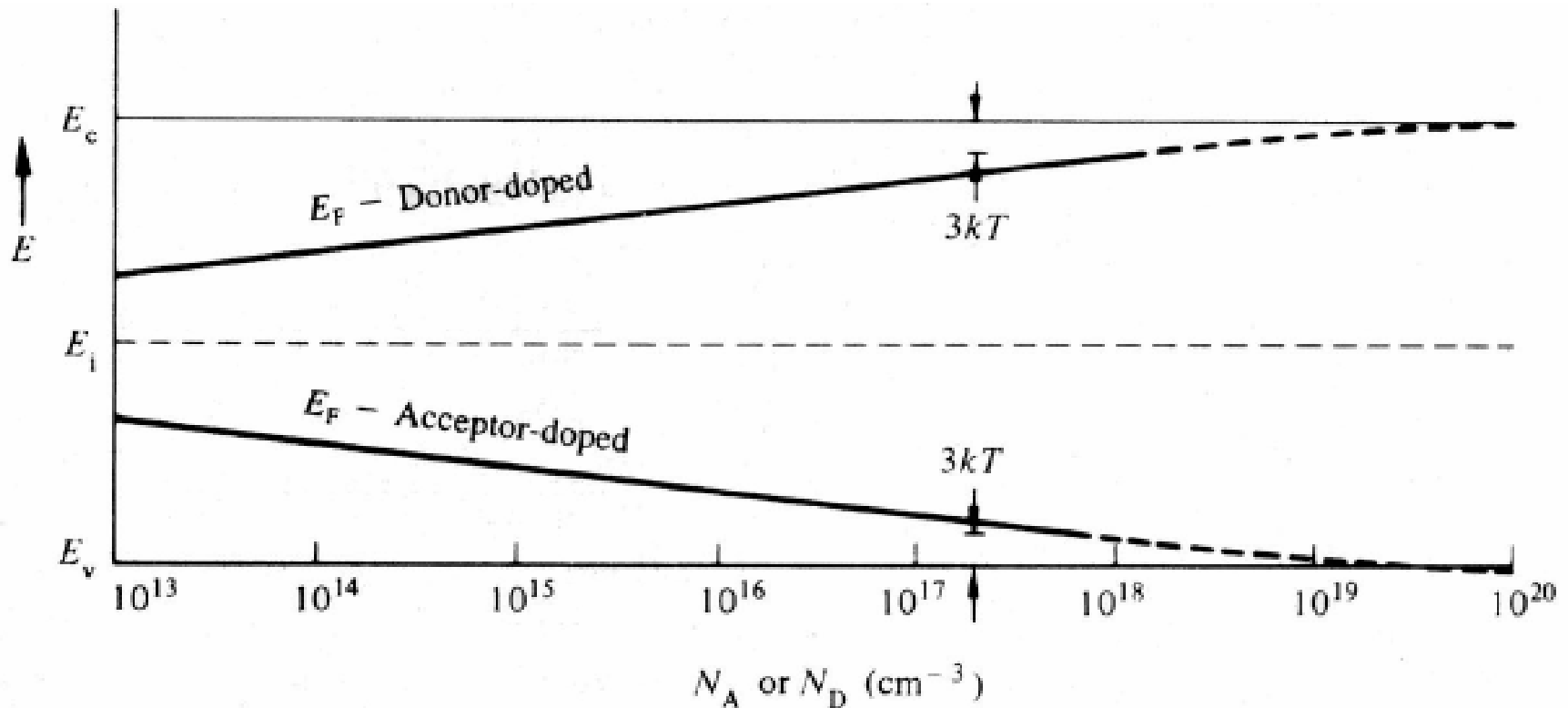
*or for  $N_D \gg N_A$  and  $N_D \gg n_i$*

$$E_F - E_i = kT \ln\left(\frac{N_D}{n_i}\right)$$

*or for  $N_A \gg N_D$  and  $N_A \gg n_i$*

$$E_F - E_i = -kT \ln\left(\frac{N_A}{n_i}\right)$$

# Determination of $E_F$ (Extrinsic Material)



Fermi level positioning in Si at room temperature as a function of the doping concentration. Solid  $E_F$  lines were established using Eq. (previous page)



# Carrier Concentration for the Quantum Well Devices

- Density of States 3D vs. 2D
- Carrier Concentration – 2D
- Charge Neutrality



# Density of States 3D vs. 2D

- 3D

$$g(E) = \frac{m\sqrt{2mE}}{\pi^2\hbar^3} \Rightarrow \text{Energy Dependent}$$

- 2D

$$g = \frac{m}{\pi^2\hbar^3 Lz} \Rightarrow \text{Energy Independent}$$

# Carrier Concentration – 2D

$$n = \int_{E_c}^{E_{top}} g_c(E) f(E) dE$$

$$n = \frac{m_n^* kT}{\pi^2 \hbar^3 L_z} \sum_i \ln \left[ 1 + e^{(E_{FC} - E_i) / kT} \right]$$

$$p = \frac{m_p^* kT}{\pi^2 \hbar^3 L_z} \sum_i \ln \left[ 1 + e^{(E_{FV} - E_i) / kT} \right]$$





# Charge Neutrality

$$P_{hh} + P_{lh} = N_{\Gamma} + N_X + N_L$$



# References

- Robert F. Pierret, *Semiconductor Fundamentals (VOLUME I)*, Addison-Wesley Publishing Company, 1988, chapter 2
- Robert F. Pierret, *Advanced Semiconductor Fundamentals (VOLUME VI)*, Addison-Wesley Publishing Company, 1987, chapter 4
- Ben G. Streetman and Sanjay Banerjee, *Solid State Electronic Devices*, Prentice Hall, Inc., 2000, chapter 3
- Peter S. Zory, JR., *Quantum Well Lasers*, Academic Press, 1993, chapter 1, 7

# Effective Mass of Holes - 3D

$$g_v(E) = \frac{m_p^* \sqrt{2m_p^*(E_v - E)}}{\pi^2 \hbar^3}$$
$$= \frac{m_{hh}^* \sqrt{2m_{hh}^*(E_v - E)}}{\pi^2 \hbar^3} + \frac{m_{lh}^* \sqrt{2m_{lh}^*(E_v - E)}}{\pi^2 \hbar^3}$$

$$(m_p^*)^{3/2} = (m_{hh}^*)^{3/2} + (m_{lh}^*)^{3/2}$$

$$m_p^* = \left[ (m_{hh}^*)^{3/2} + (m_{lh}^*)^{3/2} \right]^{2/3}$$